

**Notice of References Cited**

Application/Control No.

10/824,656

Applicant(s)/Patent Under  
Reexamination  
FRANZEN ET AL.

Examiner

Stephen Kapushoc

Art Unit

1634

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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	C	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Jaya S et al 'Galvanic Stripping - A Simple and Versatile Approach to Trace Analysis ' Analytical Letters, Volume 18 Issue 12 1985, pages 1441-1456.
	V	Jaya et al 'Galvanic stripping determination of sub-microgram amounts of cadmium in high purity zinc materials' Analyst 1987, 112, pages 1713 - 1715.
	W	Jaya et al 'Reductive galvanic stripping determination of lead' Analyst, 1987, 112, 955 - 958.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.